

Search Notes

Application/Control No.

10/814,572

Examiner

HABTE MERED

Applicant(s)/Patent under
Reexamination

MITCHELL ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	218	4/28/2008	HM
370	219	4/28/2008	HM
370	230	4/28/2008	HM
370	217	4/28/2008	HM
370	220	4/28/2008	HM
370	216	4/28/2008	HM
370	225-228	4/28/2008	HM
370	245	4/28/2008	HM
714	4	4/28/2008	HM
709	201	4/28/2008	HM
709	245	4/28/2008	HM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched EAST DB:USPAT, USPG-PUB, JPO, and EPo	4/28/2008	HM
Searched Palm Inventor's DB	4/28/2008	HM
Searched IEEE	4/28/2008	HM